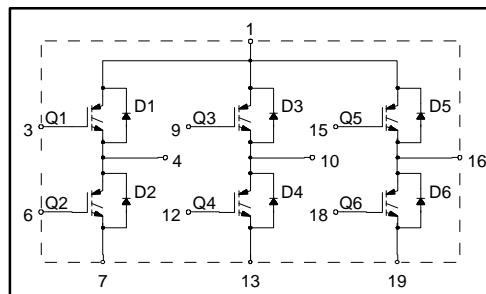


IGBT SIP MODULE

Ultra-Fast IGBT

Features

- Fully isolated printed circuit board mount package
- Switching-loss rating includes all "tail" losses
- HEXFRED™ soft ultrafast diodes
- Optimized for high operating frequency (over 5kHz)
See Fig. 1 for Current vs. Frequency curve



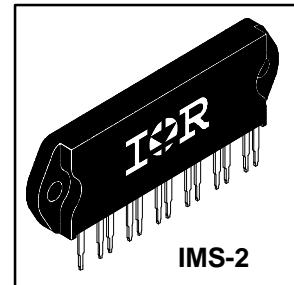
Product Summary

Output Current in a Typical 20 kHz Motor Drive

3.5 A_{RMS} per phase (1.1 kW total) with $T_C = 90^\circ\text{C}$, $T_J = 125^\circ\text{C}$, Supply Voltage 360Vdc,
Power Factor 0.8, Modulation Depth 80% (See Figure 1)

Description

The IGBT technology is the key to International Rectifier's advanced line of IMS (Insulated Metal Substrate) Power Modules. These modules are more efficient than comparable bipolar transistor modules, while at the same time having the simpler gate-drive requirements of the familiar power MOSFET. This superior technology has now been coupled to a state of the art materials system that maximizes power throughput with low thermal resistance. This package is highly suited to motor drive applications and where space is at a premium.



Absolute Maximum Ratings

	Parameter	Max.	Units	
V_{CES}	Collector-to-Emitter Voltage	600	V	
$I_C @ T_C = 25^\circ\text{C}$	Continuous Collector Current, each IGBT	7.2	A	
$I_C @ T_C = 100^\circ\text{C}$	Continuous Collector Current, each IGBT	3.9		
I_{CM}	Pulsed Collector Current ①	22		
I_{LM}	Clamped Inductive Load Current ②	22		
$I_F @ T_C = 100^\circ\text{C}$	Diode Continuous Forward Current	3.4		
I_{FM}	Diode Maximum Forward Current	22		
V_{GE}	Gate-to-Emitter Voltage	± 20		
V_{ISOL}	Isolation Voltage, any terminal to case, 1 min.	2500	V _{RMS}	
$P_D @ T_C = 25^\circ\text{C}$	Maximum Power Dissipation, each IGBT	23	W	
$P_D @ T_C = 100^\circ\text{C}$	Maximum Power Dissipation, each IGBT	9.1		
T_J	Operating Junction and	-40 to $+150$		
T_{STG}	Storage Temperature Range			
	Soldering Temperature, for 10 sec.	300 (0.063 in. (1.6mm) from case)		
	Mounting torque, 6-32 or M3 screw.	5-7 lbf·in (0.55-0.8 N·m)		

Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$ (IGBT)	Junction-to-Case, each IGBT, one IGBT in conduction	—	5.5	°C/W
$R_{\theta JC}$ (DIODE)	Junction-to-Case, each diode, one diode in conduction	—	9.0	
$R_{\theta CS}$ (MODULE)	Case-to-Sink, flat,greased surface	0.1	—	
Wt	Weight of module	20 (0.7)	—	g (oz)

CPV362MU



Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{CES}}$	Collector-to-Emitter Breakdown Voltage ③	600	—	—	V	$V_{\text{GE}} = 0\text{V}$, $I_C = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{CES}/\Delta T_J}$	Temperature Coeff. of Breakdown Voltage	—	0.69	—	V/ $^\circ\text{C}$	$V_{\text{GE}} = 0\text{V}$, $I_C = 1.0\text{mA}$
$V_{\text{CE}(\text{on})}$	Collector-to-Emitter Saturation Voltage	—	2.1	2.6	V	$I_C = 3.9\text{A}$ $V_{\text{GE}} = 15\text{V}$
		—	2.5	—		$I_C = 7.2\text{A}$ See Fig. 2, 5
		—	2.0	—		$I_C = 3.9\text{A}$, $T_J = 150^\circ\text{C}$
$V_{\text{GE}(\text{th})}$	Gate Threshold Voltage	3.0	—	5.5		$V_{\text{CE}} = V_{\text{GE}}$, $I_C = 250\mu\text{A}$
$\Delta V_{\text{GE}(\text{th})/\Delta T_J}$	Temperature Coeff. of Threshold Voltage	—	-11	—	mV/ $^\circ\text{C}$	$V_{\text{CE}} = V_{\text{GE}}$, $I_C = 250\mu\text{A}$
g_{fe}	Forward Transconductance ④	1.4	4.3	—	S	$V_{\text{CE}} = 100\text{V}$, $I_C = 6.5\text{A}$
I_{CES}	Zero Gate Voltage Collector Current	—	—	250	μA	$V_{\text{GE}} = 0\text{V}$, $V_{\text{CE}} = 600\text{V}$
		—	—	1700		$V_{\text{GE}} = 0\text{V}$, $V_{\text{CE}} = 600\text{V}$, $T_J = 150^\circ\text{C}$
V_{FM}	Diode Forward Voltage Drop	—	1.4	1.7	V	$I_C = 8.0\text{A}$ See Fig. 13
		—	1.3	1.6		$I_C = 8.0\text{A}$, $T_J = 150^\circ\text{C}$
I_{GES}	Gate-to-Emitter Leakage Current	—	—	± 500	nA	$V_{\text{GE}} = \pm 20\text{V}$

Switching Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
Q_g	Total Gate Charge (turn-on)	—	16	22	nC	$I_C = 6.5\text{A}$
Q_{ge}	Gate - Emitter Charge (turn-on)	—	2.4	3.8		$V_{\text{CC}} = 400\text{V}$
Q_{gc}	Gate - Collector Charge (turn-on)	—	7.8	13		See Fig. 8
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	22	—	ns	$T_J = 25^\circ\text{C}$
t_r	Rise Time	—	12	—		$I_C = 6.5\text{A}$, $V_{\text{CC}} = 480\text{V}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	71	95		$V_{\text{GE}} = 15\text{V}$, $R_G = 50\Omega$
t_f	Fall Time	—	91	280		Energy losses include "tail" and diode reverse recovery. See Fig. 9, 10, 11, 18
E_{on}	Turn-On Switching Loss	—	0.19	—	mJ	
E_{off}	Turn-Off Switching Loss	—	0.07	—		
E_{ts}	Total Switching Loss	—	0.26	0.42		
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	23	—	ns	$T_J = 150^\circ\text{C}$, See Fig. 9, 10, 11, 18
t_r	Rise Time	—	13	—		$I_C = 6.5\text{A}$, $V_{\text{CC}} = 480\text{V}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	140	—		$V_{\text{GE}} = 15\text{V}$, $R_G = 50\Omega$
t_f	Fall Time	—	200	—		Energy losses include "tail" and diode reverse recovery.
E_{ts}	Total Switching Loss	—	0.83	—	mJ	
C_{ies}	Input Capacitance	—	330	—		$V_{\text{GE}} = 0\text{V}$
C_{oes}	Output Capacitance	—	65	—		$V_{\text{CC}} = 30\text{V}$ See Fig. 7
C_{res}	Reverse Transfer Capacitance	—	6.0	—		$f = 1.0\text{MHz}$
t_{rr}	Diode Reverse Recovery Time	—	37	55	ns	$T_J = 25^\circ\text{C}$ See Fig.
		—	55	90		$T_J = 125^\circ\text{C}$ 14
I_{rr}	Diode Peak Reverse Recovery Current	—	3.5	5.0	A	$T_J = 25^\circ\text{C}$ See Fig.
		—	4.5	8.0		$T_J = 125^\circ\text{C}$ 15
Q_{rr}	Diode Reverse Recovery Charge	—	65	138	nC	$T_J = 25^\circ\text{C}$ See Fig.
		—	124	360		$T_J = 125^\circ\text{C}$ 16
$dI_{(\text{rec})M}/dt$	Diode Peak Rate of Fall of Recovery During t_b	—	240	—	A/ μs	$T_J = 25^\circ\text{C}$ See Fig.
		—	210	—		$T_J = 125^\circ\text{C}$ 17

Notes:

- ① Repetitive rating; $V_{\text{GE}}=20\text{V}$, pulse width limited by max. junction temperature.
(See fig. 20)
- ② $V_{\text{CC}}=80\%(V_{\text{CES}})$, $V_{\text{GE}}=20\text{V}$, $L=10\mu\text{H}$, $R_G=50\Omega$, (See fig. 19)
- ③ Pulse width $\leq 80\mu\text{s}$; duty factor $\leq 0.1\%$.
- ④ Pulse width $5.0\mu\text{s}$, single shot.

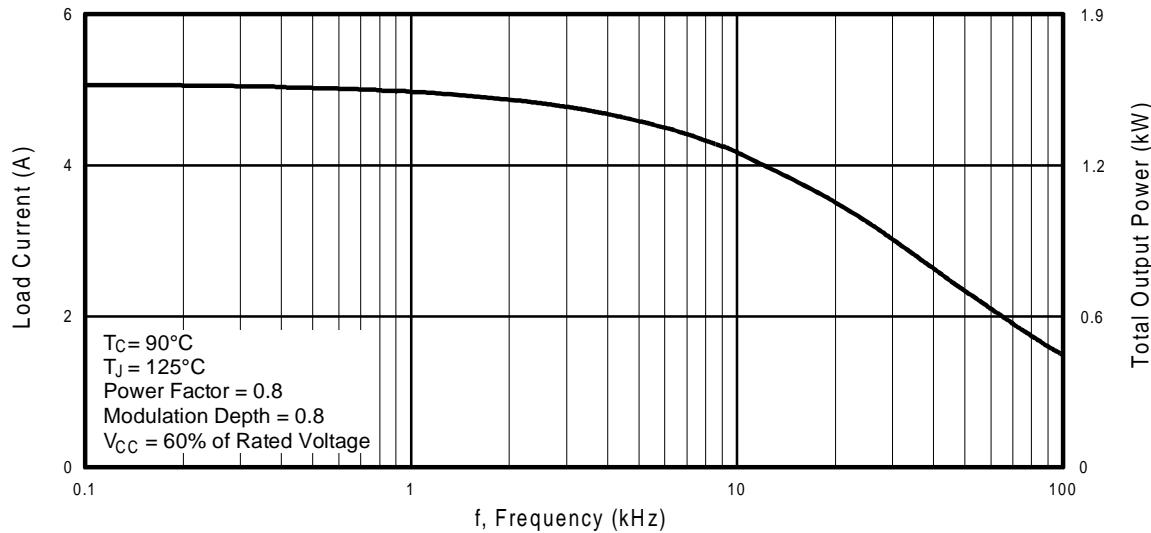


Fig. 1 - RMS Current and Output Power, Synthesized Sine Wave

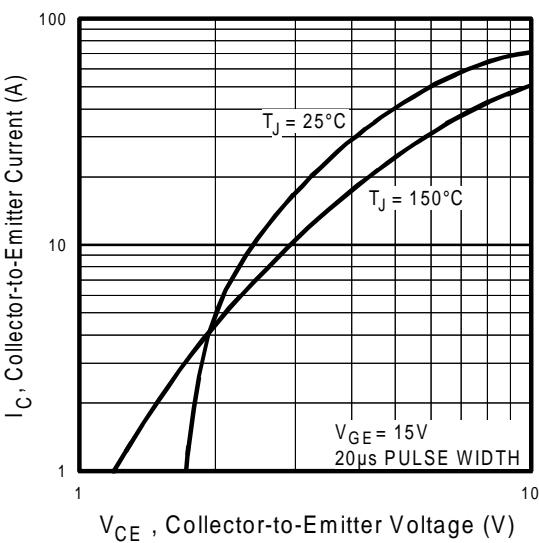


Fig. 2 - Typical Output Characteristics

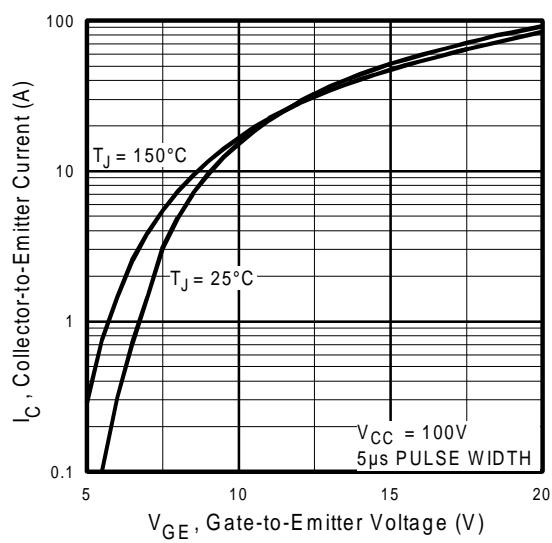


Fig. 3 - Typical Transfer Characteristics

CPV362MU

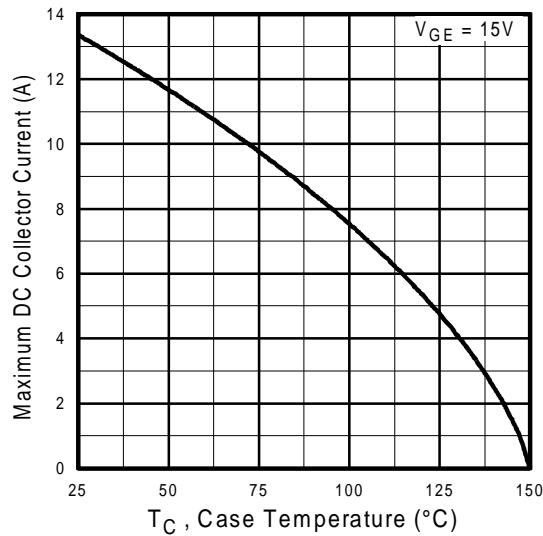


Fig. 4 - Maximum Collector Current vs. Case Temperature

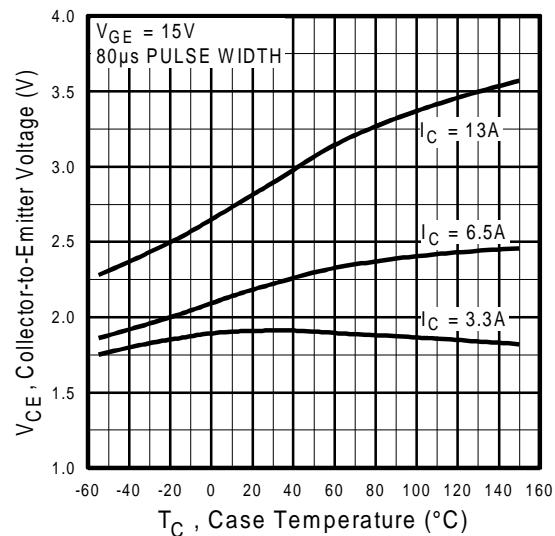


Fig. 5 - Collector-to-Emitter Voltage vs. Case Temperature

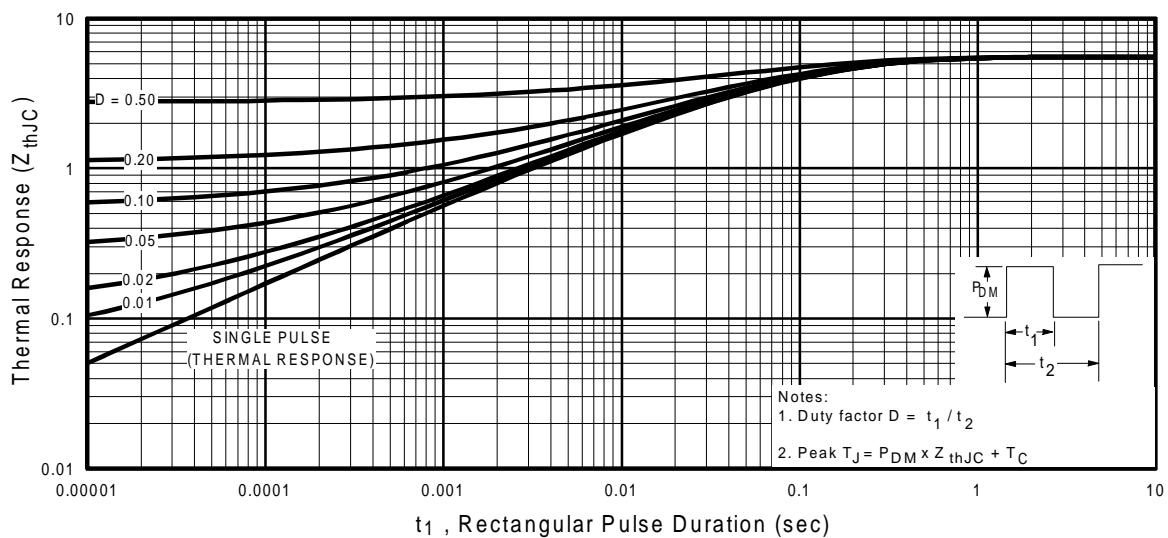
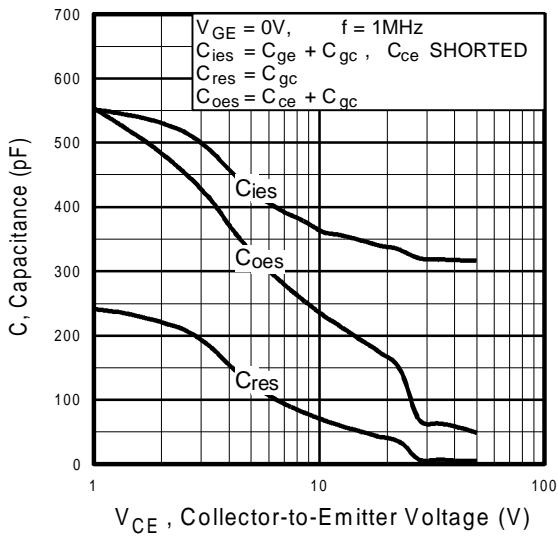
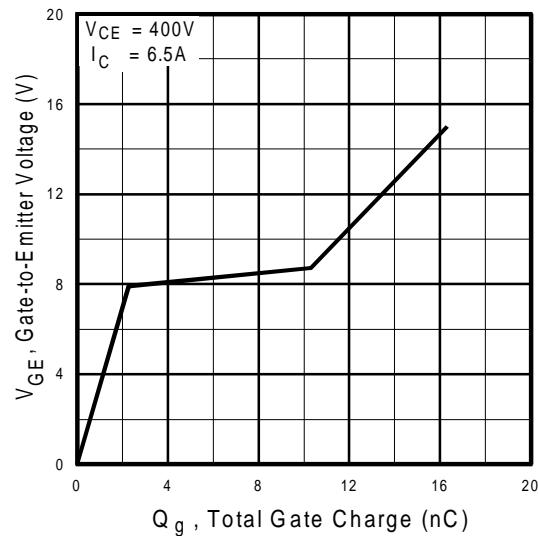


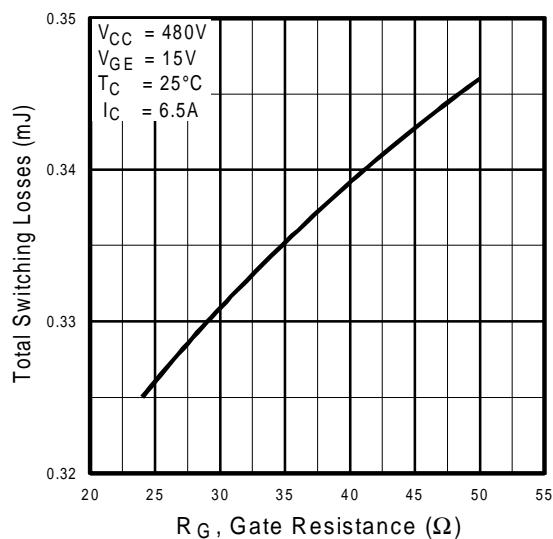
Fig. 6 - Maximum IGBT Effective Transient Thermal Impedance, Junction-to-Case



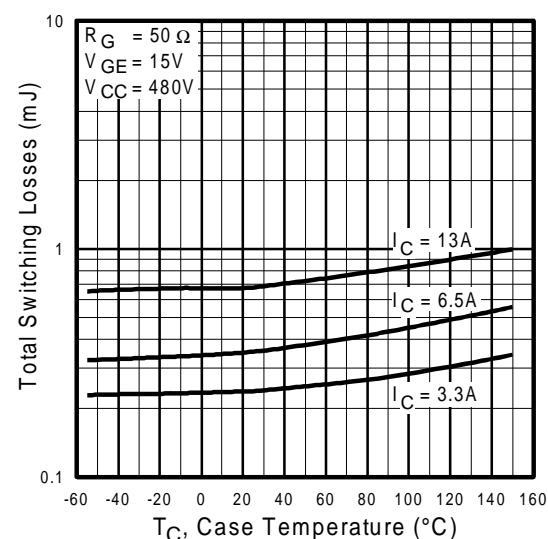
**Fig. 7 - Typical Capacitance vs.
Collector-to-Emitter Voltage**



**Fig. 8 - Typical Gate Charge vs.
Gate-to-Emitter Voltage**



**Fig. 9 - Typical Switching Losses vs. Gate
Resistance**



**Fig. 10 - Typical Switching Losses vs.
Case Temperature**

CPV362MU

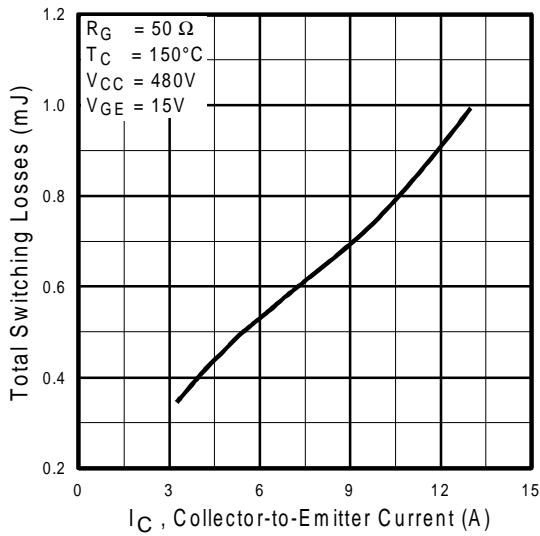


Fig. 11 - Typical Switching Losses vs.
Collector-to-Emitter Current

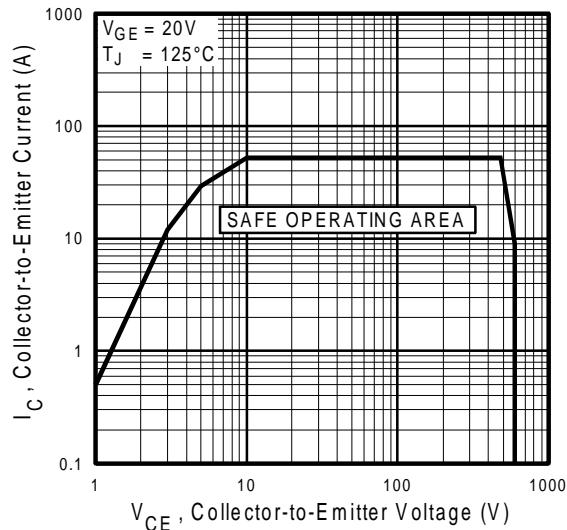


Fig. 12 - Turn-Off SOA

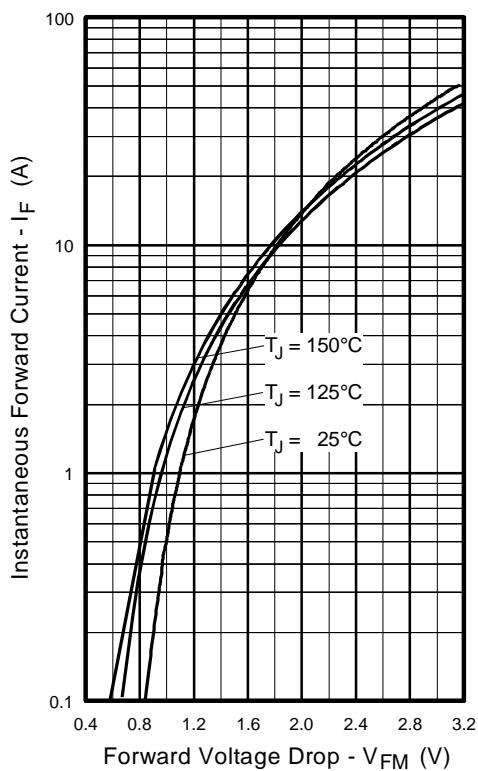


Fig. 13 - Maximum Forward Voltage Drop vs. Instantaneous Forward Current

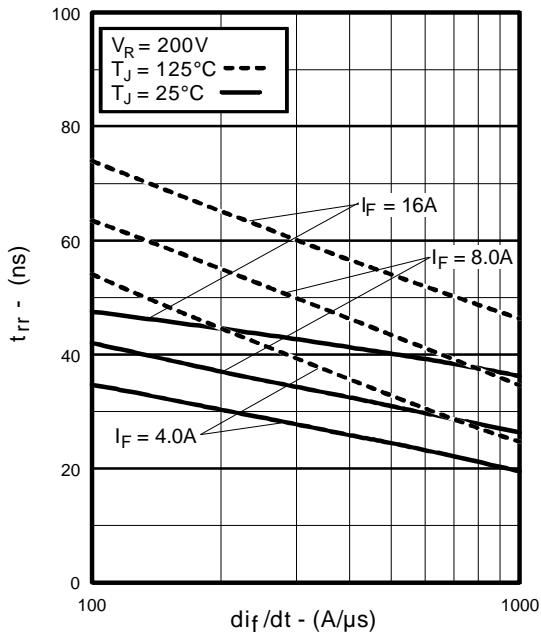


Fig. 14 - Typical Reverse Recovery vs. di_f/dt

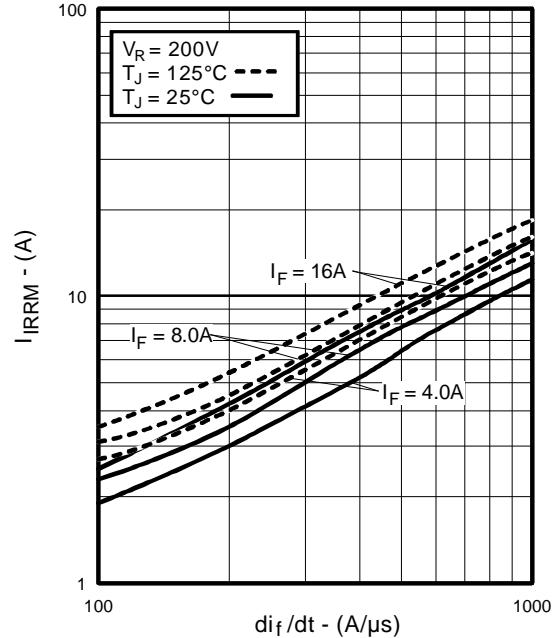


Fig. 15 - Typical Recovery Current vs. di_f/dt

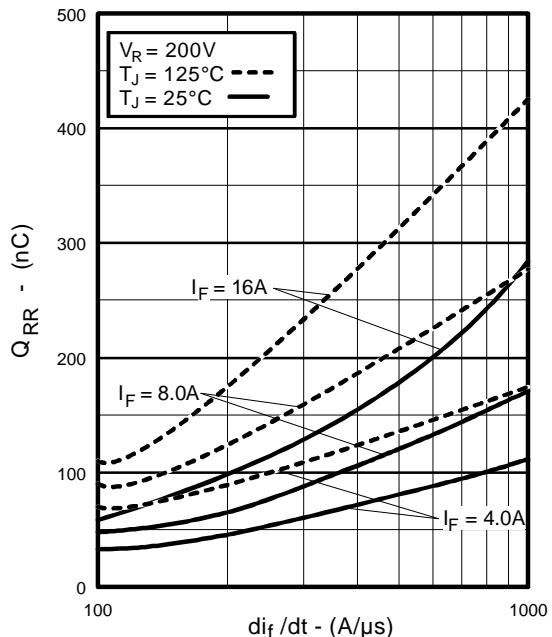


Fig. 16 - Typical Stored Charge vs. di_f/dt

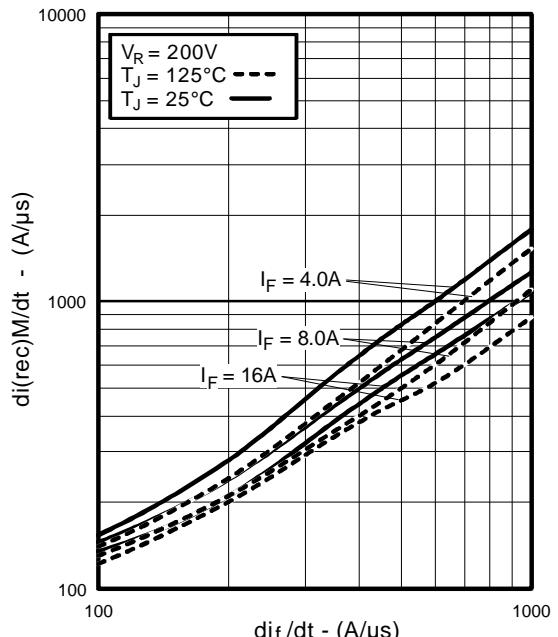


Fig. 17 - Typical $di_{(rec)M}/dt$ vs. di_f/dt

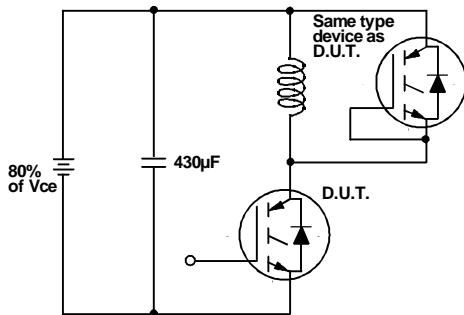


Fig. 18a - Test Circuit for Measurement of
 I_{LM} , E_{on} , $E_{off(diode)}$, t_{rr} , Q_{rr} , I_{rr} , $t_d(on)$, t_r , $t_d(off)$, t_f

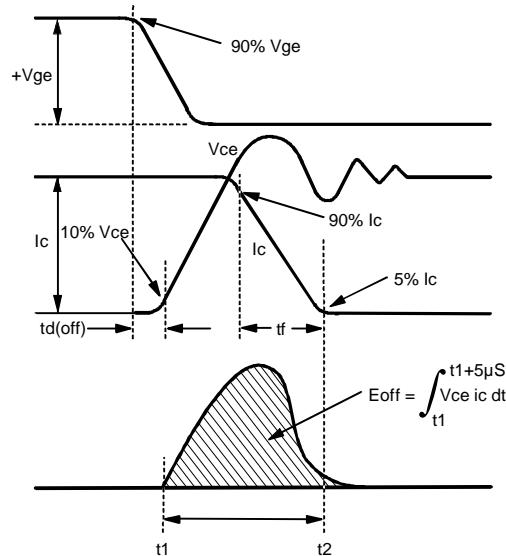


Fig. 18b - Test Waveforms for Circuit of Fig. 18a, Defining
 E_{off} , $t_{d(off)}$, t_f

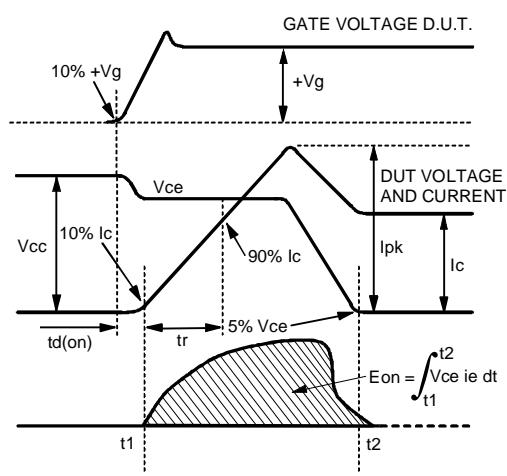


Fig. 18c - Test Waveforms for Circuit of Fig. 18a,
Defining E_{on} , $t_{d(on)}$, t_r

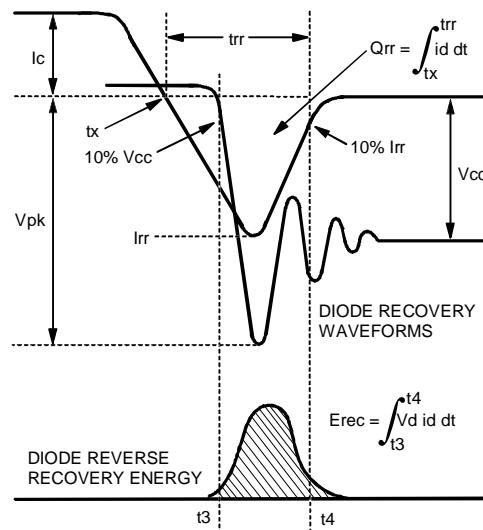


Fig. 18d - Test Waveforms for Circuit of Fig. 18a,
Defining E_{rec} , t_{rr} , Q_{rr} , I_{rr}

Refer to Section D for the following:
Appendix D: Section D - page D-6

- Fig. 18e - Macro Waveforms for Test Circuit of Fig. 18a
- Fig. 19 - Clamped Inductive Load Test Circuit
- Fig. 20 - Pulsed Collector Current Test Circuit

Package Outline 5 - IMS-2 Package (13 pins)

Section D - page D-14